


<i>Search Notes</i> 	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10552315	AKHAPKINA ET AL.
	Examiner	Art Unit
	Kim, Jennifer	1617

SEARCHED			
Class	Subclass	Date	Examiner
514	408, 545	3/15/2007	jmk
	Updated	7/30/2007	jmk
	Updated	2/13/2008	jmk
	Updated	8/6/2008	jmk
	Updated STN	2/19/2009	jmk

SEARCH NOTES		
Search Notes	Date	Examiner
Registry; inventor search; international search report; chemdraw	3/15/2007	jmk
Updated; STN (registry) see serach terms.	7/30/2007	jmk
Updated	2/13/2008	jmk
Updated	8/6/2008	jmk
Updated STN	2/19/2009	jmk

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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